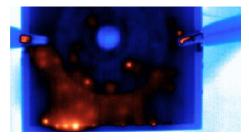


MoviTHERM Solar-Check is a turnkey infrared non-destructive testing (*ir*NDT) system developed for solar cell inspection that includes an infrared camera, excitation source, and image processing software. The built-in lock-in thermography (LiT) measurement technique responds to thermal responses from the solar cell at the exact excitation frequency, thereby dramatically improving the overall sensitivity of the system to micro-Kelvin levels. Additionally, the LiT technique is not susceptible to the adverse effects of reflections or thermal diffusion significantly enhancing the appearance of defects. Solar-Check can be used for all common IR solar cell testing methods including crack detection, shunt detection, emission analysis, and carrier density measurements.

### **Features**

- Non-contact irNDT
- Lock-In Thermography Analysis
- Functional Circuit Analysis (Power Dissipation, Shorts, etc.)
- Effective on low emissivity targets
- Multiple Lens Options for Wide Angle and Close-up imaging



IR image of 60x60mm silicon solar cell showing shunt defects (orange areas) under steady state reverse bias conditions.



Same 60x60mm cell with Lock-in technique applied. Note the elimination of reflections and thermal diffusion interferences for easy fault identification.

# **Key Benefits**

#### **NON-CONTACT TESTING**

Active irNDT thermography for common solar cell testing.

- ✓ Crack Detection
- ✓ Shunt Detection
- Emission Analysis
- ✓ Carrier Density Measurements

### **FLEXIBLE AND EXPANABLE**

Upgrade a system by adding lenses, enclosures, stages, and IR cameras.

- ✓ Works with Cooled and Uncooled IR Cameras
- ✓ Multiple lens configuration for wide angle and close-up testing

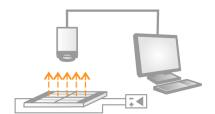
#### irNDT MADE EASY

Complex analysis technology simplified for inspection.

- Effective measurement on low and varying emissivity targets
- ✓ No Surface Preparation Required
- ✓ Large and small area measurement
- Quick and reliable defect detection

## How does it work?

Solar-Check works by means of Lock-in Thermography (LiT) which consists of applying a periodic pulsed electrical signal to the test device and monitoring the resultant temperature variation with a synchronized thermal camera. A computer captures multiple IR images and applies a processing algorithm to produce a surface map identifying localized hotspots. LiT produces images with greater resolution and temperature distribution over passive IR thermography.



# **Specifications**

Uncooled Infrared Camera Options			Cooled Infrared Camera Options	
Available Resolutions	336 x 256 or 640 x 512		Available Resolutions	640 x 512 or 1280 x 1024
Image Rate	30 Hz / 60 Hz		Image Rate	60 Hz / 120 Hz / 181 Hz / 1000 Hz
Thermal Sensitivity	< 30 mK @ 30°C		Thermal Sensitivity	< 20 mK @ 30°C
PC				
PC Type		Office PC, Industry PC, Laptop (for mobile use)		
Supported Operating Systems		Windows 10 Pro 64-bit		
Excitation Source				
Electrical Excitation		0 – 10V input, 0-70V output Programable Power Supply		
IRX-Box				
Modulation Box for Synchronization of all Hardware and Software Components				
Enables Easy and Compact Measuring Setups				
irNDT-Software				
Evaluation Modules for Lock-in, Photovoltaic Cell Inspection				
Graphical User Interface for easy creation of customized solutions without programming skills				
Integrated MS Excel Report Generator for easy set-up of inspection reports, export of inspection data to Matlab, sorting of inspection parameters in workspaces, and storing of result images include measuring parameters				
Integrated VB Script-Engine for the creation of macros for solving automated inspection tasks				
Result Viewer App – Allows for calibrated spatial defect measurements				
Measuring and Analysis Properties				
Parameters for the Excitation Source • Recta		Rectangle W	unctions: Pulse, Sine, Trapezoid, Rectangle, User-Defined Function Width at Rectangle Modulation: 0.1 – 0.9% Frequency: 1μHz – 50kHz	
Parameters for the IR Camer	ers for the IR ( amera		ncy, Integration Time, Temperature Range, Average tector Window, etc.	
Parameters for the Analysis		Automatic N	special Functions for Inspection of Photovoltaic Cells Automatic Noise Reduction Functions and Compensation of exterior Interferences in all analysis modules	

<sup>\*</sup>Specifications subject to change without notice. 11/2021

